In the Claims:

(Currently Amended) A chemical mechanical polishing method, comprising:
 determining a vertical position of a top surface of a polishing pad in a chemical
 mechanical polishing system using a pad height sensor by

determining a distance between the pad height sensor positioned above the polishing pad and the polishing pad, and

subtracting the determined distance from a known distance between the pad height sensor and a surface on which the polishing pad rests;

positioning a window disposed in an aperture of the polishing pad such that the top surface of the window is at about the same vertical position of the top surface of the pad based on the determination; and polishing a wafer.

- (Original) The method of claim 1, further comprising:
 determining an endpoint of the polishing; and
 stopping the polishing upon reaching the endpoint.
- 3. (Original) The method of claim 1, further comprising draining slurry and waste product from the aperture.
- (Original) The method of claim 1, further comprising:
 lowering the window; and
 conditioning the pad after lowering the window.

5. (Original) The method of claim 1, wherein the window is coated with a slurry-phobic substance.

- 6. (Cancelled)
- 7. (Original) The method of claim 1, further comprising:
 positioning additional windows disposed in apertures of the polishing pad such
 that the top surface of each window is at about same vertical position of the top surface of
 the pad.
- 8. (Original) A CMP system, comprising:
 a polishing pad having an aperture;
 a pad height sensor positioned above the polishing pad;
 a window vertically moveable within the aperture; and
 a window raising mechanism capable of adjusting the vertical position of the
 window based on information from the pad height sensor.
- 9. (Original) The system of claim 8, further comprising an endpoint measurement sensor positioned beneath the window.
- 10. (Original) The system of claim 8, further comprising a drain disposed in the aperture.

- 11. (Original) The system of claim 8, further comprising a pad dresser.
- 12. (Original) The system of claim 8, wherein the window is coated with a slurry-phobic substance.
- 13. (Original) The system of claim 8, further comprising additional windows, each window disposed in an additional aperture of the polishing pad, and wherein each window is movable between a lowered position and raised position at about the height of the polishing pad as determined by the pad height sensor.
- 14. (Original) The system of claim 8, wherein the window rests on an inflatable toroid coupled to a pump.
- 15. (Original) The system of claim 8, wherein the window rests on a plurality of cylinders, each partially disposed in an airtight chamber coupled to a solenoid valve.
- 16. (Original) A CMP system, comprising:

means for determining a vertical position of a top surface of a polishing pad in a chemical mechanical polishing system;

means for positioning a window disposed in an aperture of the polishing pad such that the top surface of the window is at about the same vertical position of the top surface of the pad based on feedback from the means for determining and

means for polishing a wafer.

17. (Original) A CMP control system, comprising:

a rate/height data structure holding data indicating the relationship between the vertical position of a window disposed within an aperture of a polishing pad and control data for a window-raising mechanism;

a sensor engine capable of receiving distance data from a pad height sensor positioned above the polishing pad;

a pump engine, communicatively coupled to the sensor engine and the data structure, capable of sending commands to the window-raising mechanism based on control data related to the received distance data, to raise the window to about the height of the polishing pad.

- 18. (Original) The system of claim 17, wherein the window raising mechanism is a pump coupled to an inflatable toroid.
- 19. (Original) The system of claim 17, wherein the window raising mechanism is a solenoid valve coupled to a plurality of chambers having cylinders disposed therein.
- 20. (Original) A computer-readable medium having stored thereon instructions to cause a computer to execute a method, the method comprising:

receiving distance data from a pad height sensor positioned above a polishing pad; calculating a height of the polishing pad based on the received distance data; and

transmitting an instruction to a window-raising mechanism based on the calculation that will the raise a window disposed within an aperture of a polishing pad to about the calculated height of the polishing pad.

- 21. (Original) The computer-readable medium of claim 20, wherein the window raising mechanism is a pump coupled to an inflatable toroid.
- 22. (Original) The computer-readable medium of claim 20, wherein the window raising mechanism is a solenoid valve coupled to a plurality of chambers having cylinders disposed therein.
- 23. (Cancelled)
- 24. (Cancelled)
- 25. (Cancelled)